

<b>Notice of References Cited</b>	Application/Control No. 10/521,444		Applicant(s)/Patent Under Reexamination FINK, STEVEN T.	
	Examiner SATISH CHANDRA		Art Unit 1792	Page 1 of 1

#### U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,634,845	10-2003	Komino, Mitsuaki	414/217
*	B	US-6,382,249	05-2002	Kawasaki et al.	137/565.3
*	C	US-7,030,037	04-2006	Doan et al.	438/758
*	D	US-5,391,260	02-1995	Makino et al.	216/69
*	E	US-2001/0016166	08-2001	Dandl et al.	417/48
*	F	US-6,178,918	01-2001	van Os et al.	118/723R
*	G	US-2003/0038111	02-2003	Carducci et al.	216/59
*	H	US-5,685,942	11-1997	Ishii, Nobuo	156/345.48
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

#### FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

#### NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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	V	
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	X	

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